Search Notes



Application/Control No. Applicant(s)/Patent Under Reexamination 10690330 KIM ET AL.

Examiner Art Unit

Feben M Haile 2616

SEARCHED

| Class | Subclass | Date | Examiner | | |
|-------|---|-----------|----------|--|--|
| 370 | 392, 395.51, 395.53, 466, 469, 471, 474 | 3/12/2008 | FH | | |
| 398 | 45, 58, 63 | 3/12/2008 | FH | | |
| 710 | 30 | 3/12/2008 | FH | | |

SEARCH NOTES

| Search Notes | Date | Examiner |
|--|-----------|----------|
| mac, frame, ethernet, optical, pon, epon, llid, tag, label, indentifier, physical layer, data layer, olt, onu, add, tag, reconfigure, append, affix, annex, flag, field, insert, stack | 3/12/2008 | FH |
| Consulted Aung Moe | 9/23/2008 | FH |
| Updated Search | 9/25/2008 | FH |

INTERFERENCE SEARCH

| Class | Subclass | Date | Examiner | | |
|-------|----------|-----------|----------|--|--|
| 370 | 469, 392 | 9/25/2008 | FH | | |

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